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Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
<i>an</i>	JJ	US 5 594 676	01/1997	Greggain et al.			
	KK	US 5 594 843	01/1997	O'Neill			
	LL	US 5 594 844	01/1997	Sakai et al.			
	MM	US 5 594 845	01/1997	Florent et al.			
	NN	US 5 608 850	03/1997	Robertson			
	OO	US 5 613 048	03/1997	Chen et al.			
	PP	US 5 630 037	05/1997	Schindler			
	QQ	US 5 646 679	07/1997	Yano et al.			
	RR	US 5 649 032	07/1997	Burt et al.			
	SS	US 5 650 814	07/1997	Florent et al.			
	TT	US 5 748 194	05/1998	Chen			
<i>in</i>	UU	US 5 963 213	10/1999	Guedalia et al.			

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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	L							
	M							
	N							
	O							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
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Examiner <i>Cl Lu</i>	Date Considered <i>11/17/03</i>	

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